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| Notice of References Cited | Application/Control No. 10/558,385 | | Applicant(s)/Patent Under Reexamination ITO ET AL. | |
| | Examiner ARLEEN M. VAZQUEZ | | Art Unit 2829 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--------------------------------------------------|-----------------|----------------------|----------------|
| * | A | US-4,980,971 | 01-1991 | Bartschat et al. | 29/833 |
| * | B | US-5,694,219 | 12-1997 | Kim, Hyo Won | 356/615 |
| * | C | US-5,481,202 | 01-1996 | Frye, Jr., Ronald E. | 324/754 |
| * | D | US-5,946,409 | 08-1999 | Hori, Nobuhiro | 382/149 |
| * | E | US-5,113,132 | 05-1992 | Hoshi, Seiichi | 324/758 |
| * | F | US-5,084,959 | 02-1992 | Ando et al. | 29/740 |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--------------------------------------------------|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|-------------------------------------------------------------------------------------------|
| | U | |
| | V | |
| | W | |
| | X | |

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